



PIC24HJ32GP302/304, PIC24HJ64GPX02/X04 and PIC24HJ128GPX02/X04

PIC24HJ32GP302/304, PIC24HJ64GPX02/X04 and PIC24HJ128GPX02/X04 Family Silicon Errata and Data Sheet Clarification

The PIC24HJ32GP302/304, PIC24HJ64GPX02/X04 and PIC24HJ128GPX02/X04 family devices that you have received conform functionally to the current Device Data Sheet (DS70293G), except for the anomalies described in this document.

The silicon issues discussed in the following pages are for silicon revisions with the Device and Revision IDs listed in [Table 1](#). The silicon issues are summarized in [Table 2](#).

The errata described in this document will be addressed in future revisions of the PIC24HJ32GP302/304, PIC24HJ64GPX02/X04 and PIC24HJ128GPX02/X04 silicon.

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated in the last column of [Table 2](#) apply to the current silicon revision (A5).

Data Sheet clarifications and corrections start on [Page 11](#), following the discussion of silicon issues.

The silicon revision level can be identified using the current version of MPLAB® IDE and Microchip's programmers, debuggers and emulation tools, which are available at the Microchip corporate web site (www.microchip.com).

For example, to identify the silicon revision level using MPLAB IDE in conjunction with MPLAB ICD 3 or PICkit™ 3:

1. Using the appropriate interface, connect the device to the MPLAB ICD 3 programmer/debugger or PICkit 3.
2. From the main menu in MPLAB IDE, select *Configure>Select Device*, and then select the target part number in the dialog box.
3. Select the MPLAB hardware tool (*Debugger>Select Tool*).
4. Perform a "Connect" operation to the device (*Debugger>Connect*). Depending on the development tool used, the part number *and* Device Revision ID value appear in the **Output** window.

Note: If you are unable to extract the silicon revision level, please contact your local Microchip sales office for assistance.

The Device and Revision ID values for the various PIC24HJ32GP302/304, PIC24HJ64GPX02/X04 and PIC24HJ128GPX02/X04 silicon revisions are shown in [Table 1](#).

TABLE 1: SILICON DEVREV VALUES

Part Number	Device ID ⁽¹⁾	Revision ID for Silicon Revision ⁽²⁾				
		A1	A2	A3	A4	A5
PIC24HJ32GP302	0x0645	0x3001	0x3002	0x3002	0x3003	0x3004
PIC24HJ32GP304	0x0647					
PIC24HJ64GP202	0x0655					
PIC24HJ64GP204	0x0657					
PIC24HJ64GP502	0x0675					
PIC24HJ64GP504	0x0677					

- Note 1:** The Device and Revision IDs (DEVID and DEVREV) are located at the last two implemented addresses in program memory.
- 2:** Refer to the "dsPIC33F/PIC24H Flash Programming Specification" (DS70152) for detailed information on Device and Revision IDs for your specific device.

TABLE 1: SILICON DEVREV VALUES (CONTINUED)

Part Number	Device ID ⁽¹⁾	Revision ID for Silicon Revision ⁽²⁾				
		A1	A2	A3	A4	A5
PIC24HJ128GP202	0x0665	0x3001	0x3002	0x3002	0x3003	0x3004
PIC24HJ128GP204	0x0667					
PIC24HJ128GP502	0x067D					
PIC24HJ128GP504	0x067F					

Note 1: The Device and Revision IDs (DEVID and DEVREV) are located at the last two implemented addresses in program memory.

2: Refer to the “dsPIC33F/PIC24H Flash Programming Specification” (DS70152) for detailed information on Device and Revision IDs for your specific device.

TABLE 2: SILICON ISSUE SUMMARY

Module	Feature	Item Number	Issue Summary	Affected Revisions ⁽¹⁾				
				A1	A2	A3	A4	A5
UART	IR Mode	1.	The 16x baud clock signal on the BCLK pin is present only when the module is transmitting.	X	X	X	X	X
UART	High-Speed Mode	2.	When the UARTx is in 4x mode (BRGH = 1) and using two Stop bits (STSEL = 1), it may sample the first Stop bit instead of the second one.	X	X	X	X	X
SPI	Transmit Operation	3.	The SPIx Transmit Buffer Full (SPITBF) flag does not get set immediately after writing to the buffer.	X	X	X	X	X
SPI	Frame Mode	4.	The SPIx module will generate incorrect frame synchronization pulses in Frame Master mode if FRMDLY = 1.	X	X	X	X	X
I ² C™	SFR Writes	5.	The BCL bit in I2CxSTAT can only be cleared with word instructions, and can be corrupted with byte instructions and bit operations.	X	X	X	X	X
I ² C	10-Bit Addressing	6.	When the I ² C module is configured for 10-bit addressing using the same Address bits (A10 and A9) as other I ² C devices, A10 and A9 bits may not work as expected.	X	X	X	X	X
I ² C	10-Bit Addressing	7.	When the I ² C module is configured as a 10-bit slave with an address of 0x02, the I2CxRCV register content for the lower address byte is 0x01 rather than 0x02.	X	X	X	X	X
I ² C	—	8.	With the I ² C module enabled, the PORT bits and external interrupt input functions (if any), associated with SCLx and SDAx pins, will not reflect the actual digital logic levels on the pins.	X	X	X	X	X
I ² C	10-Bit Addressing	9.	The 10-bit slave does not set the RBF flag or load the I2CxRCV register on address match if the Least Significant bits (LSBs) of the address are the same as the 7-bit reserved addresses.	X	X	X	X	X
I ² C	—	10.	After the ACKSTAT bit is set when receiving a NACK, it may be cleared by the reception of a Start or Stop bit.	X	X	X	X	X

Note 1: Only those issues indicated in the last column apply to the current silicon revision.

TABLE 2: SILICON ISSUE SUMMARY (CONTINUED)

Module	Feature	Item Number	Issue Summary	Affected Revisions ⁽¹⁾				
				A1	A2	A3	A4	A5
UART	Interrupts	11.	The UART error interrupt may not occur, or may occur at an incorrect time, if multiple errors occur during a short period of time.	X	X	X	X	X
UART	IR Mode	12.	When the UARTx module is operating in 8-bit mode (PDSEL<1:0> = 0x) and using the IrDA [®] encoder/decoder (IREN = 1), the module incorrectly transmits a data payload of 80h as 00h.	X	X	X	X	X
Comparator	Output Pin	13.	When CxOUTEN (CMCON) is set, the comparator output pin cannot be used as a general purpose I/O pin even if the comparator is disabled.	X	X	X	X	X
Internal Voltage Regulator	Sleep Mode	14.	When the VREGS bit (RCON<8>) is set to a logic '0', the device may reset and higher Sleep current may be observed.	X	X	X	X	X
PSV Operations	—	15.	An address error trap occurs in certain addressing modes when accessing the first four bytes of any PSV page.	X	X	X	X	X
ECAN™	Sleep Mode	16.	The WAKIF bit in the CiINTF register cannot be cleared by a software instruction after the device is interrupted from Sleep due to activity on the CAN bus.	X	X	X	X	X
ECAN	Receive Operation	17.	The ECAN module may not store the received data in the correct location.	X	X	X		
CPU	EXCH Instruction	18.	The EXCH instruction does not execute correctly.	X	X	X	X	X
SPI	Transmit Operation	19.	Writing to the SPIxBUF register as soon as the TBF bit is cleared will cause the SPIx module to ignore written data.	X	X	X	X	X
UART	Break Character Generation	20.	The UARTx module will not generate back-to-back Break characters.	X	X	X	X	X
ADC	Current Consumption in Sleep Mode	21.	If the ADC module is in an enabled state when the device enters Sleep mode, the Power-Down (IPD) current of the device may exceed the device data sheet specifications.	X	X	X	X	X
RTCC	Boundary Scan	22.	On 28-pin devices, JTAG boundary scan does not function correctly for Pin 7. Both Pins 6 and 7 respond to stimulus applied to Pin 7.	X	X	X	X	X
JTAG	Operation During Reset	23.	The RTCC module gets reset on any device Reset, instead of getting reset only on a POR or BOR.	X	X	X	X	X
All	150°C Operation	24.	These revisions of silicon only support 140°C operation instead of 150°C for high-temperature operating temperature.	X	X	X		
I/O Port	Data Direction Setting	25.	When the RB8 pin is in open-drain configuration, the data direction depends upon the TRISB9 bit instead of the TRISB8 bit.	X	X	X	X	X

Note 1: Only those issues indicated in the last column apply to the current silicon revision.

TABLE 2: SILICON ISSUE SUMMARY (CONTINUED)

Module	Feature	Item Number	Issue Summary	Affected Revisions ⁽¹⁾				
				A1	A2	A3	A4	A5
CPU	Interrupt Disable	26.	When a previous <code>DISI</code> instruction is active (i.e., the <code>DISICNT</code> register is non-zero), and the value of the <code>DISICNT</code> register is updated manually, the <code>DISICNT</code> register freezes and disables interrupts permanently.	X	X	X	X	X
CPU	<code>div.sd</code>	27.	When using the <code>div.sd</code> instruction, the Overflow bit is not getting set when an overflow occurs.	X	X	X	X	X
UART	TX Interrupt	28.	A Transmit (TX) interrupt may occur before the data transmission is complete.	X	X	X	X	X
JTAG	Flash Programming	29.	JTAG Flash programming is not supported.	X	X	X	X	X

Note 1: Only those issues indicated in the last column apply to the current silicon revision.

Silicon Errata Issues

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated by the shaded column in the following tables apply to the current silicon revision (A5).

1. Module: UART

When the UARTx is configured for IR interface operations (UxMODE<9:8> = 11), the 16x baud clock signal on the BCLK pin is present only when the module is transmitting. The pin is Idle at all other times.

Work around

Configure one of the output compare modules to generate the required baud clock signal when the UARTx is receiving data or in an Idle state.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

2. Module: UART

When the UARTx is in 4x mode (BRGH = 1) and using two Stop bits (STSEL = 1), it may sample the first Stop bit instead of the second one.

This issue does not affect the other UART configurations.

Work around

Use the 16x baud rate option (BRGH = 0) and adjust the baud rate accordingly.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

3. Module: SPI

The SPIx Transmit Buffer Full (SPITBF) flag does not get set immediately after writing to the buffer.

Work around

After a write to the SPIx buffer, poll the SPITBF flag until the flag gets set, indicating that the transmit buffer is not full. Afterwards, poll the SPITBF flag again until the flag gets cleared, indicating that the transmit has started, and that the transmit buffer is empty and another write can occur.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

4. Module: SPI

The SPI module will generate incorrect frame synchronization pulses when configured in Frame Master mode if the start of data is selected to coincide with the start of the frame synchronization pulse (FRMEN = 1, SPIFSD = 0, FRMDLY = 1). However, the module functions correctly in Frame Slave mode and also in Frame Master mode if FRMDLY = 0.

Work around

If DMA is not being used, manually drive the \overline{SSx} pin (x = 1 or 2) high using the associated PORT register, and then drive it low after the required 1 bit time pulse width. This operation needs to be performed when the transmit buffer is written.

If DMA is being used, and if no other peripheral modules are using DMA transfers, use a timer interrupt to periodically generate the frame synchronization pulse (using the method described above) after every 8 or 16-bit period (depending on the data word size, configured using the MODE16 bit).

If FRMDLY = 0, no work around is needed.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

5. Module: I²C™

The BCL bit in I2CxSTAT can only be cleared with word instructions, and can be corrupted with byte instructions and bit operations.

Work around

Use word instructions to clear BCL.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

6. Module: I²C

If there are two I²C devices on the bus, one of them is acting as the master receiver and the other as the slave transmitter. If both devices are configured for 10-Bit Addressing mode, and have the same value in the A10 and A9 bits of their addresses, then when the slave select address is sent from the master, both the master and slave Acknowledge it. When the master sends out the read operation, both the master and the slave enter into Read mode and both of them transmit the data. The resultant data will be the ANDing of the two transmissions.

Work around

In all I²C devices, the addresses, as well as bits, A10 and A9, should be different.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

7. Module: I²C

When the I²C module is configured as a 10-bit slave with an address of 0x02, the I2CxRCV register content for the lower address byte is 0x01 rather than 0x02; however, the module Acknowledges both address bytes.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

8. Module: I²C

With the I²C module enabled, the PORT bits and external interrupt input functions (if any), associated with the SCLx and SDAx pins, do not reflect the actual digital logic levels on the pins.

Work around

If the SDAx and/or SCLx pins need to be polled, these pins should be connected to other port pins in order to be read correctly. This issue *does not* affect the operation of the I²C module.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

9. Module: I²C

In 10-Bit Addressing mode, some address matches do not set the RBF flag or load the receive register, I2CxRCV, if the lower address byte matches the reserved addresses. In particular, these include all addresses with the form, 'xx0000xxxx' and 'xx1111xxxx', with the following exceptions:

- 001111000x
- 011111001x
- 101111010x
- 111111011x

Work around

Ensure that the lower address byte in 10-Bit Addressing mode does not match any 7-bit reserved addresses.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

10. Module: I²C

When the I²C module is operating in either Master or Slave mode, after the ACKSTAT bit is set when receiving a NACK, it may be cleared by the reception of a Start or Stop bit.

Work around

Store the value of the ACKSTAT bit immediately after receiving a NACK.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

11. Module: UART

The UARTx error interrupt may not occur, or may occur at an incorrect time, if multiple errors occur during a short period of time.

Work around

Read the error flags in the UxSTA register whenever a byte is received to verify the error status. In most cases, these bits will be correct, even if the UARTx error interrupt fails to occur.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

12. Module: UART

When the UARTx is operating in 8-bit mode (PDSEL<1:0> = 0x) and using the IrDA encoder/decoder (IREN = 1), the module incorrectly transmits a data payload of 80h as 00h.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

13. Module: Comparator

If CxOUTEN (CMCON) is set and the Comparator Enable bit, CxEN (CMCON) is disabled, the remappable Comparator Output pins, C1OUT and C2OUT, cannot be used as general purpose I/O pins.

Work around

When the comparator module is disabled the CxOUTEN bit should be reset so that the remappable Comparator Output pins, C1OUT and C2OUT, are not driven onto the output pad.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

14. Module: Internal Voltage Regulator

When the VREGS bit (RCON<8>) is set to a logic '0', the device may reset and higher Sleep current may be observed.

Work around

Ensure the VREGS bit (RCON<8>) is set to a logic '1' for device Sleep mode operation.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

15. Module: PSV Operations

An address error trap occurs in certain addressing modes when accessing the first four bytes of a PSV page. This only occurs when using the following addressing modes:

- MOV.D
- Register Indirect Addressing (Word or Byte mode) with Pre/Post-Decrement

Work around

Do not perform PSV accesses to any of the first four bytes using the above addressing modes. For applications using the C language, MPLAB C30, Version 3.11 or higher, provides the following command-line switch that implements a work around for the erratum.

```
-merrata=psv_trap
```

Refer to the `readme.txt` file in the MPLAB C30 v3.11 toolsuite for further details.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

16. Module: ECAN™

The WAKIF bit in the CiINTF register cannot be cleared by software instruction after device is interrupted from Sleep due to activity on the CAN bus.

When the device wakes up from Sleep due to CAN bus activity, the ECAN module is placed in operational mode. The ECAN event interrupt occurs due to the WAKIF flag. Trying to clear the flag in the Interrupt Service Routine (ISR) may not clear the flag. The WAKIF bit being set will not cause repetitive Interrupt Service Routine execution.

Work around

Although the WAKIF bit does not clear, the device, Sleep and ECAN wake function continues to work as expected. If the ECAN event is enabled, the CPU will enter the Interrupt Service Routine due to the WAKIF flag getting set. The application can maintain a secondary flag, which tracks the device Sleep and wake events.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

17. Module: ECAN

The ECAN module may not store received data in the correct location. When this occurs, the receive buffers will become corrupted. In addition, it is also possible for the transmit buffers to become corrupted. This issue is more likely to occur as the CAN bus speed approaches 1 Mbps.

Work around

Do not use the DMA with ECAN in Peripheral Indirect mode. Use the DMA in Register Indirect mode, Continuous mode enabled and Ping Pong mode disabled. The receive DMA channel count should be set to 8 words. The transmit DMA channel count should be set for the actual message size (maximum of 7 words for Extended CAN messages and 6 words for Standard CAN Messages). To simplify application error handling while using this mode, only one TX buffer should be used. While message filtering is not affected, messages will not be stored at distinct RX buffers. Instead, all messages are stored contiguously in memory. The start of this memory is pointed to by the receive DMA channel. The application must still clear RXFULx flags and other interrupt flags. The application must manage the RX buffer memory.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X					

18. Module: CPU

The EXCH instruction does not execute correctly.

Work around

If writing source code in assembly, the recommended work around is to replace:

```
EXCH Wsource, Wdestination
```

with:

```
PUSH Wdestination
MOV Wsource, Wdestination
POP Wsource
```

If using the MPLAB C30 C compiler, specify the compiler option: `-merrata=exch` (*Project > Build Options > Projects > MPLAB C30 > Use Alternate Settings*).

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

19. Module: SPI

Writing to the SPIxBUF register, as soon as the TBF bit is cleared, will cause the SPIx module to ignore the written data. Applications which use SPI with DMA will not be affected by this erratum.

Work around

After the TBF bit is cleared, wait for a minimum duration of one SPI clock before writing to the SPIxBUF register.

Alternatively, do one of the following:

- Poll the RBF bit and wait for it to get set before writing to the SPIxBUF register
- Poll the SPI interrupt flag and wait for it to get set before writing to the SPIxBUF register
- Use an SPI Interrupt Service Routine
- Use DMA

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

20. Module: UART

The UARTx module will not generate consecutive Break characters. Trying to perform a back-to-back Break character transmission will cause the UARTx module to transmit the dummy character used to generate the first Break character, instead of transmitting the second Break character. Break characters are generated correctly if they are followed by non-Break character transmission.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

21. Module: ADC

If the ADC module is in an enabled state when the device enters Sleep mode as a result of executing a `PWRSVAV #0` instruction, the device Power-Down (IPD) current may exceed the specifications listed in the device data sheet. This may happen even if the ADC module is disabled by clearing the ADON bit prior to entering Sleep mode.

Work around 1:

In order to remain within the IPD specifications listed in the device data sheet, the user software must completely disable the ADC module by setting the ADC module disable bit in the corresponding Peripheral Module Disable register (PMDx), prior to executing a `PWRSVAV #0` instruction.

Note: The ADC module must be reinitialized by the user application before resuming ADC operation.

Work around 2:

If the ADC module was previously initialized and enabled before entering Sleep, execute the lines of code provided in [Example 1](#).

Note: Unlike **Work around 1**, the user application does not need to reinitialize the ADC module; however, it is necessary to re-enable the ADC module by setting the ADON bit after waking from Sleep.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

EXAMPLE 1:

```
AD1CON1bits.ADON = 0;           //Disable the ADC module
__asm__ volatile ("REPEAT #50"); //Wait 50 Tcy
__asm__ volatile ("NOP");       //Repeat NOP 51 times
Sleep();                        // Execute PWRSVAV #0 and go to Sleep
```

22. Module: RTCC

The RTCC module gets reset on any device Reset, instead of getting reset only on a POR or BOR.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

23. Module: JTAG

On 28-pin devices, JTAG boundary scan does not function correctly for Pin 7. Both Pins 6 and 7 respond to stimulus applied to Pin 7.

Work around

Do not include Pin 7 in the JTAG boundary scan chain for 28-pin devices.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

24. Module: All

The affected silicon revisions listed below are not warranted for operation at +150°C.

Work around

Only use the affected revisions of silicon for high-temperature operating range, from -40°C to +140°C.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X					

25. Module: I/O Port

When the ODCB8 bit is set to '1' (open-drain configuration), the data direction on the RB8 pin is controlled by the TRISB9 bit instead of the TRISB8 bit.

Work around

Do not use the RB8 pin in open-drain configuration while simultaneously using the RB9 pin.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

26. Module: CPU

When a previous `DISI` instruction is active (i.e., the `DISICNT` register is non-zero), and the value of the `DISICNT` register is updated manually, the `DISICNT` register freezes and disables interrupts permanently.

Work around

Avoid updating the `DISICNT` register manually. Instead, use the `DISI #n` instruction with the required value for 'n'.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

27. Module: CPU

When using the Signed 32-bit by 16-bit Division instruction, `div.sd`, the Overflow bit does not always get set when an overflow occurs.

Work around

Test for and handle overflow conditions outside of the `div.sd` instruction.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

28. Module: UART

When using `UTXISEL<1:0> = 01` (interrupt when last character is shifted out of the Transmit Shift Register) and the final character is being shifted out through the Transmit Shift Register, the Transmit (TX) interrupt may occur before the final bit is shifted out.

Work around

If it is critical that the interrupt processing occur only when all transmit operations are complete, hold off the interrupt routine processing by adding a loop at the beginning of the routine that polls the Transmit Shift Register Empty bit (TRMT) before processing the rest of the interrupt.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

29. Module: JTAG

JTAG Flash programming is not supported.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

Data Sheet Clarifications

The following typographic corrections and clarifications are to be noted for the latest version of the device data sheet (DS70293G):

Note: Corrections are shown in **bold**. Where possible, the original bold text formatting has been removed for clarity.

1. Module: Electrical Characteristics

For Parameter DC60d (Power-Down Current) in Table 28-7, the maximum value is corrected to read as 85 μ A.

2. Module: Electrical Characteristics

For Parameter DI51d (Input Leakage Current) in Table 28-9, the value is corrected to read as $\pm 12 \mu$ A.

3. Module: Electrical Characteristics

For Parameter F21 (Internal RC Accuracy) in Table 28-19, the values for the temperature range of -40°C to $+85^{\circ}\text{C}$ are corrected to read as -30% for minimum and $+30\%$ for maximum.

4. Module: Electrical Characteristics

[Table 28-18](#): AC Characteristics: Internal RC Accuracy should be replaced with the following table.

TABLE 28-18: AC CHARACTERISTICS: INTERNAL RC ACCURACY

AC CHARACTERISTICS		Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated)					
		Operating temperature $-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$ for Industrial $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ for Extended					
Param No.	Characteristic	Min	Typ ⁽²⁾	Max	Units	Conditions	
Internal FRC Accuracy @ 7.3728 MHz⁽¹⁾							
F20	FRC	-3	—	3	%	$-40^{\circ}\text{C} \leq T_A \leq -10^{\circ}\text{C}$	$V_{DD} = 3.0\text{-}3.6\text{V}$
	FRC	-2	—	2	%	$-10^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$	$V_{DD} = 3.0\text{-}3.6\text{V}$
	FRC	-5	—	5	%	$+85^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	$V_{DD} = 3.0\text{-}3.6\text{V}$

Note 1: Frequency calibrated at $+25^{\circ}\text{C}$ and 3.3V. TUNx bits can be used to compensate for temperature drift.

Note 2: Negative current is defined as current sourced by the pin.

5. Module: High-Temperature Electrical Characteristics

A new table, [Table 29-8](#): DC Characteristics: I/O Pin Input Specifications and Parameter HDI51f (Input Leakage Current, AN9-AN12), are added to this chapter under DC Characteristics. They are shown in [Table 29-8](#) below. The following tables in this chapter will be renumbered sequentially.

TABLE 29-8: DC CHARACTERISTICS: I/O PIN INPUT SPECIFICATIONS

DC CHARACTERISTICS			Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \leq T_A \leq +150^{\circ}\text{C}$ for Extended Temperature				
Param No.	Symbol	Characteristic	Min	Typ ⁽¹⁾	Max	Units	Conditions
HDI51f	IIL	Input Leakage Current, AN9 through AN12	—	—	±15	µA	VSS ≤ VPIN ≤ VDD, Pin at high-impedance, $-40^{\circ}\text{C} \leq T_A \leq +150^{\circ}\text{C}$

Note 1: Negative current is defined as current sourced by the pin.

6. Module: High-Temperature Electrical Characteristics

A new table, [Table 29-19](#): AC Characteristics: Internal RC Accuracy, is added to this chapter under AC Characteristics. [Table 29-19](#) summarizes the internal oscillator tolerance over the entire temperature range.

TABLE 29-19: AC CHARACTERISTICS: INTERNAL RC ACCURACY

AC CHARACTERISTICS		Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \leq T_A \leq +150^{\circ}\text{C}$ for High Temperature					
Param No.	Characteristic	Min	Typ ⁽¹⁾	Max	Units	Conditions	
HF20	FRC ⁽²⁾	-5	—	5	%	$-40^{\circ}\text{C} \leq T_A \leq +150^{\circ}\text{C}$	VDD = 3.0-3.6V

Note 1: Negative current is defined as current sourced by the pin.

2: Frequency calibrated at +25°C and 3.3V. TUNx bits can be used to compensate for temperature drift.

APPENDIX A: REVISION HISTORY

Rev A Document (3/2009)

Initial release of this document; issued for revision A1, A2 and A3 silicon.

Includes silicon issues 1-2 ([UART](#)), 3-4 ([SPI](#)), 5-10 ([I²C™](#)), 11-12 ([UART](#)), 13 ([Comparator](#)), 14 ([Internal Voltage Regulator](#)), 15 ([PSV Operations](#)), 16-17 ([ECAN™](#)), 18 ([CPU](#)) and 19 ([SPI](#)).

This document replaces the following errata document:
“*PIC24HJ32GP302/304, PIC24HJ64GPX02/X04 and PIC24HJ128GPX02/X04 Rev. A1/A2/A3 Silicon Errata*”
(DS80373)

Rev B Document (4/2009)

Corrected part numbers.

Rev C Document (8/2009)

Added silicon issue 20 ([UART](#)).

Rev D Document (1/2010)

Added Rev. A4 silicon information.

Rev E Document (6/2010)

Updated silicon issue 18 ([CPU](#)).

Added silicon issues 21 ([ADC](#)), 22 ([RTCC](#)) and 23 ([JTAG](#)), and data sheet clarification 1 ([DC Characteristics: I/O Pin Input Specifications](#)).

Rev F Document (10/2010)

Updated the work around in silicon issue 21 ([ADC](#)).

Added silicon issue 24 ([All](#)).

Rev G Document (3/2011)

Removed data sheet clarification 1.

Updated the Affected Silicon Revisions for item 24 in [Table 2](#) and in silicon issue 24 ([All](#)).

Added silicon issue 25 ([I/O Port](#)).

Rev H Document (11/2011)

Updated the current Device Data Sheet revision to “F”.

Added Rev. A5 silicon information.

Added silicon issues 26 ([CPU](#)), 27 ([CPU](#)), 28 ([UART](#)), and 29 ([JTAG](#)).

Rev J Document (7/2013)

Updated the current Device Data Sheet revision to “G”.

Added data sheet clarifications 1 through 4 ([Electrical Characteristics](#)) and data sheet clarifications 5 through 6 ([High-Temperature Electrical Characteristics](#)).

Other minor typographic changes have been made to improve table readability.

NOTES:

Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as “unbreakable.”

Code protection is constantly evolving. We at Microchip are committed to continuously improving the code protection features of our products. Attempts to break Microchip's code protection feature may be a violation of the Digital Millennium Copyright Act. If such acts allow unauthorized access to your software or other copyrighted work, you may have a right to sue for relief under that Act.

Information contained in this publication regarding device applications and the like is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, MERCHANTABILITY OR FITNESS FOR PURPOSE. Microchip disclaims all liability arising from this information and its use. Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights.

Trademarks

The Microchip name and logo, the Microchip logo, dsPIC, FlashFlex, KEELOQ, KEELOQ logo, MPLAB, PIC, PICmicro, PICSTART, PIC³² logo, rPIC, SST, SST Logo, SuperFlash and UNI/O are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

FilterLab, Hampshire, HI-TECH C, Linear Active Thermistor, MTP, SEEVAL and The Embedded Control Solutions Company are registered trademarks of Microchip Technology Incorporated in the U.S.A.

Silicon Storage Technology is a registered trademark of Microchip Technology Inc. in other countries.


Analog-for-the-Digital Age, Application Maestro, BodyCom, chipKIT, chipKIT logo, CodeGuard, dsPICDEM, dsPICDEM.net, dsPICworks, dsSPEAK, ECAN, ECONOMONITOR, FanSense, HI-TIDE, In-Circuit Serial Programming, ICSP, Mindi, MiWi, MPASM, MPF, MPLAB Certified logo, MPLIB, MPLINK, mTouch, Omniclient Code Generation, PICC, PICC-18, PICDEM, PICDEM.net, PICkit, PICtail, REAL ICE, rLAB, Select Mode, SQI, Serial Quad I/O, Total Endurance, TSHARC, UniWinDriver, WiperLock, ZENA and Z-Scale are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

GestIC and ULPP are registered trademarks of Microchip Technology Germany II GmbH & Co. KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

© 2009-2013, Microchip Technology Incorporated, Printed in the U.S.A., All Rights Reserved.

 Printed on recycled paper.

ISBN: 978-1-62077-352-9

QUALITY MANAGEMENT SYSTEM
CERTIFIED BY DNV
== ISO/TS 16949 ==

Microchip received ISO/TS-16949:2009 certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona; Gresham, Oregon and design centers in California and India. The Company's quality system processes and procedures are for its PIC[®] MCUs and dsPIC[®] DSCs, KEELOQ[®] code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.



MICROCHIP

Worldwide Sales and Service

AMERICAS

Corporate Office
2355 West Chandler Blvd.
Chandler, AZ 85224-6199
Tel: 480-792-7200
Fax: 480-792-7277
Technical Support:
<http://www.microchip.com/support>
Web Address:
www.microchip.com

Atlanta
Duluth, GA
Tel: 678-957-9614
Fax: 678-957-1455

Boston
Westborough, MA
Tel: 774-760-0087
Fax: 774-760-0088

Chicago
Itasca, IL
Tel: 630-285-0071
Fax: 630-285-0075

Cleveland
Independence, OH
Tel: 216-447-0464
Fax: 216-447-0643

Dallas
Addison, TX
Tel: 972-818-7423
Fax: 972-818-2924

Detroit
Farmington Hills, MI
Tel: 248-538-2250
Fax: 248-538-2260

Indianapolis
Noblesville, IN
Tel: 317-773-8323
Fax: 317-773-5453

Los Angeles
Mission Viejo, CA
Tel: 949-462-9523
Fax: 949-462-9608

Santa Clara
Santa Clara, CA
Tel: 408-961-6444
Fax: 408-961-6445

Toronto
Mississauga, Ontario,
Canada
Tel: 905-673-0699
Fax: 905-673-6509

ASIA/PACIFIC

Asia Pacific Office
Suites 3707-14, 37th Floor
Tower 6, The Gateway
Harbour City, Kowloon
Hong Kong
Tel: 852-2401-1200
Fax: 852-2401-3431

Australia - Sydney
Tel: 61-2-9868-6733
Fax: 61-2-9868-6755

China - Beijing
Tel: 86-10-8569-7000
Fax: 86-10-8528-2104

China - Chengdu
Tel: 86-28-8665-5511
Fax: 86-28-8665-7889

China - Chongqing
Tel: 86-23-8980-9588
Fax: 86-23-8980-9500

China - Hangzhou
Tel: 86-571-2819-3187
Fax: 86-571-2819-3189

China - Hong Kong SAR
Tel: 852-2943-5100
Fax: 852-2401-3431

China - Nanjing
Tel: 86-25-8473-2460
Fax: 86-25-8473-2470

China - Qingdao
Tel: 86-532-8502-7355
Fax: 86-532-8502-7205

China - Shanghai
Tel: 86-21-5407-5533
Fax: 86-21-5407-5066

China - Shenyang
Tel: 86-24-2334-2829
Fax: 86-24-2334-2393

China - Shenzhen
Tel: 86-755-8864-2200
Fax: 86-755-8203-1760

China - Wuhan
Tel: 86-27-5980-5300
Fax: 86-27-5980-5118

China - Xian
Tel: 86-29-8833-7252
Fax: 86-29-8833-7256

China - Xiamen
Tel: 86-592-2388138
Fax: 86-592-2388130

China - Zhuhai
Tel: 86-756-3210040
Fax: 86-756-3210049

ASIA/PACIFIC

India - Bangalore
Tel: 91-80-3090-4444
Fax: 91-80-3090-4123

India - New Delhi
Tel: 91-11-4160-8631
Fax: 91-11-4160-8632

India - Pune
Tel: 91-20-2566-1512
Fax: 91-20-2566-1513

Japan - Osaka
Tel: 81-6-6152-7160
Fax: 81-6-6152-9310

Japan - Tokyo
Tel: 81-3-6880-3770
Fax: 81-3-6880-3771

Korea - Daegu
Tel: 82-53-744-4301
Fax: 82-53-744-4302

Korea - Seoul
Tel: 82-2-554-7200
Fax: 82-2-558-5932 or
82-2-558-5934

Malaysia - Kuala Lumpur
Tel: 60-3-6201-9857
Fax: 60-3-6201-9859

Malaysia - Penang
Tel: 60-4-227-8870
Fax: 60-4-227-4068

Philippines - Manila
Tel: 63-2-634-9065
Fax: 63-2-634-9069

Singapore
Tel: 65-6334-8870
Fax: 65-6334-8850

Taiwan - Hsin Chu
Tel: 886-3-5778-366
Fax: 886-3-5770-955

Taiwan - Kaohsiung
Tel: 886-7-213-7828
Fax: 886-7-330-9305

Taiwan - Taipei
Tel: 886-2-2508-8600
Fax: 886-2-2508-0102

Thailand - Bangkok
Tel: 66-2-694-1351
Fax: 66-2-694-1350

EUROPE

Austria - Wels
Tel: 43-7242-2244-39
Fax: 43-7242-2244-393

Denmark - Copenhagen
Tel: 45-4450-2828
Fax: 45-4485-2829

France - Paris
Tel: 33-1-69-53-63-20
Fax: 33-1-69-30-90-79

Germany - Munich
Tel: 49-89-627-144-0
Fax: 49-89-627-144-44

Italy - Milan
Tel: 39-0331-742611
Fax: 39-0331-466781

Netherlands - Drunen
Tel: 31-416-690399
Fax: 31-416-690340

Spain - Madrid
Tel: 34-91-708-08-90
Fax: 34-91-708-08-91

UK - Wokingham
Tel: 44-118-921-5869
Fax: 44-118-921-5820

11/29/12